



### N-CHANNEL ENHANCEMENT MODE MOSFET

### **Product Summary**

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> max	I <sub>D</sub> max T <sub>A</sub> = 25°C
	40mΩ @ V <sub>GS</sub> = 10V	5.5A
60V	55mΩ @ V <sub>GS</sub> = 4.5V	4.7A

## **Description and Applications**

This MOSFET has been designed to minimize the on-state resistance (R<sub>DS(on)</sub>) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

- Backlighting
- **Power Management Functions**
- **DC-DC Converters**

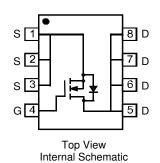
## **Features and Benefits**

- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 standards for High Reliability

## **Mechanical Data**

- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections Indicator: See diagram
- Terminals: Finish Matte Tin annealed over Copper leadframe. Solderable per MIL-STD-202, Method 208 (3)
- Weight: 0.008 grams (approximate)





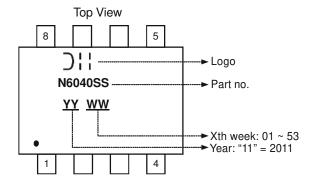
Ordering Information (Note 4)

Part Number	Case	Packaging
DMN6040SSS-13	SO-8	2500/Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + CI) and 1000ppm antimony compounds.
  4. For packaging details, go to our website at http://www.diodes.com.

# **Marking Information**





## Maximum Ratings @TA = 25°C unless otherwise specified

Characteristic			Symbol	Value	Units
Drain-Source Voltage			$V_{DSS}$	60	V
Gate-Source Voltage			$V_{GSS}$	±20	V
Section Residence (Note State		$T_A = 25$ °C $T_A = 70$ °C	I <sub>D</sub>	5.5 4.4	Α
Continuous Drain Current (Note 6) V <sub>GS</sub> = 10V	t<10s	$T_A = 25$ °C $T_A = 70$ °C	Ι <sub>D</sub>	7.0 5.5	А
Maximum Continuous Body Diode Forward Current (Note 6)			I <sub>S</sub>	2.5	Α
Pulsed Drain Current (10μs pulse, duty cycle = 1%)			I <sub>DM</sub>	30	Α
Avalanche Current (Note 7) L = 0.1mH			I <sub>AR</sub>	14.2	Α
Repetitive Avalanche Energy (Note 7) L = 0.1mH			E <sub>AR</sub>	10	mJ

# Thermal Characteristics @TA = 25°C unless otherwise specified

Characteristic	Symbol	Value	Units	
Total Power Dissipation (Note 5)	$T_A = 25^{\circ}C$	$P_{D}$	1.5	W
Total Fower Dissipation (Note 3)	$T_A = 70$ °C	FD	1	VV
Thermal Resistance, Junction to Ambient (Note 5)	Steady State	_	80	°C/W
Thermal Resistance, Junction to Ambient (Note 5)	t<10s	$R_{\theta JA}$	48	
Total Bower Dissipation (Note 6)	$T_A = 25^{\circ}C$	D-	2.0	W
Total Power Dissipation (Note 6)	$T_A = 70$ °C	$P_{D}$	1.3	VV
Thermal Pagistance, Junction to Ambient (Note 6)	Steady State	0	61	°C/W
Thermal Resistance, Junction to Ambient (Note 6)	t<10s	$R_{\theta JA}$	37	
Thermal Resistance, Junction to Case		$R_{ heta JC}$	6.4	
Operating and Storage Temperature Range	$T_{J,}T_{STG}$	-55 to 150	°C	

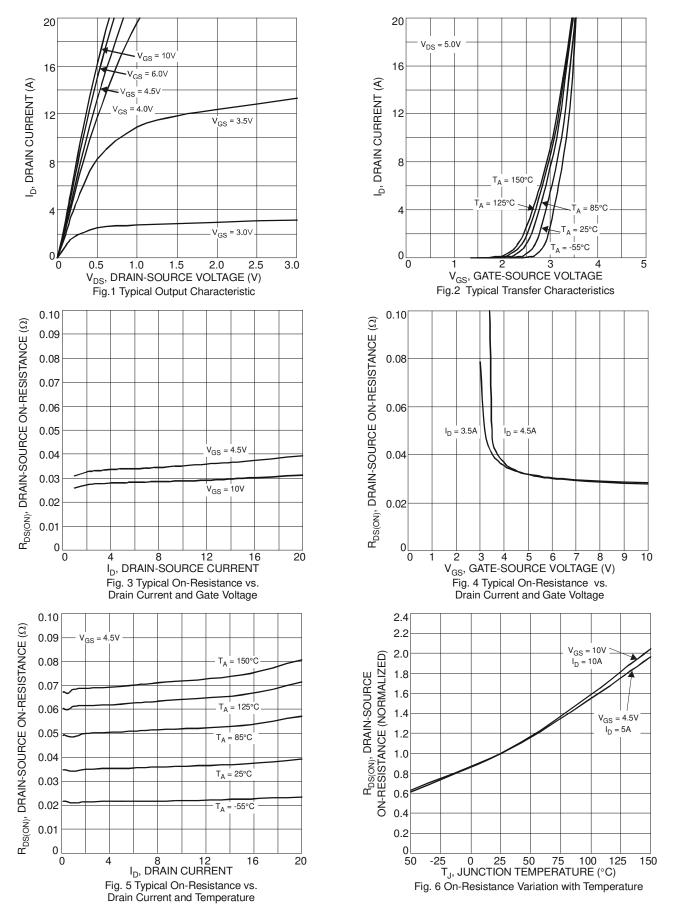
## **Electrical Characteristics** T<sub>A</sub> = 25°C unless otherwise specified

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 8)							
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	60	_	_	V	$V_{GS} = 0V, I_D = 250\mu A$	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	_	_	100	nA	$V_{DS} = 60V, V_{GS} = 0V$	
Gate-Source Leakage	I <sub>GSS</sub>	_	_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 8)			•	•			
Gate Threshold Voltage	V <sub>GS(th)</sub>	1	_	3	V	$V_{DS} = V_{GS}, I_D = 250 \mu A$	
Static Drain-Source On-Resistance		_	30	40	mΩ	V <sub>GS</sub> = 10V, I <sub>D</sub> = 4.5A	
Static Drain-Source On-nesistance	R <sub>DS (ON)</sub>	_	35	55		$V_{GS} = 4.5V, I_D = 3.5A$	
Forward Transfer Admittance	Y <sub>fs</sub>	_	4.5	_	S	$V_{DS} = 10V, I_D = 4.3A$	
Diode Forward Voltage	V <sub>SD</sub>	_	0.7	1.2	V	$V_{GS} = 0V, I_{S} = 1A$	
DYNAMIC CHARACTERISTICS (Note 9)							
Input Capacitance	C <sub>iss</sub>	_	1287	_		V <sub>DS</sub> = 25V, V <sub>GS</sub> = 0V f = 1.0MHz	
Output Capacitance	C <sub>oss</sub>		57	_	рF		
Reverse Transfer Capacitance	C <sub>rss</sub>	_	44	_			
Gate Resistance	R <sub>G</sub>	_	1.2	_	Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1.0MHz$	
Total Gate Charge (V <sub>GS</sub> = 10V)	Qg	_	22.4	_		1	
Total Gate Charge (V <sub>GS</sub> = 4.5V)	Qg		10.4	_	~_	V 200V I 4.0A	
Gate-Source Charge	Q <sub>gs</sub>	_	4.9	_	nC	$V_{DS} = 30V, I_D = 4.3A$	
Gate-Drain Charge	Q <sub>gd</sub>	_	3.0	_			
Turn-On Delay Time	t <sub>D(on)</sub>	_	6.6	_		$V_{GS}=10V,V_{DD}=30V,R_{G}=6\Omega,$ $I_{D}=4.3A$	
Turn-On Rise Time	tr	_	8.1	_			
Turn-Off Delay Time	t <sub>D(off)</sub>	_	20.1	_	nS		
Turn-Off Fall Time	t <sub>f</sub>	_	4.0	_			
Body Diode Reverse Recovery Time	t <sub>rr</sub>	_	18	_	nS	I <sub>S</sub> = 4.3A, dI/dt = 100A/μs	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	_	11.9	_	nC $I_S = 4.3A$ , $dI/dt = 100A/\mu s$		

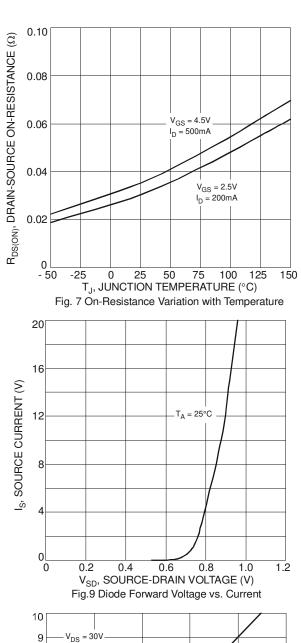
5. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout. 6. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate. 7.  $I_{AB}$  and  $E_{AB}$  rating are based on low frequency and duty cycles to keep  $T_J$  = 25°C Notes:

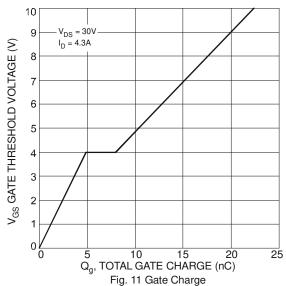
<sup>8.</sup> Short duration pulse test used to minimize self-heating effect. 9. Guaranteed by design. Not subject to product testing.











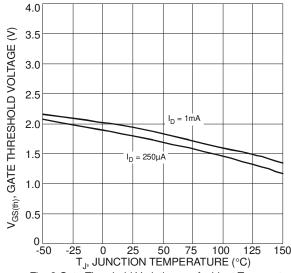
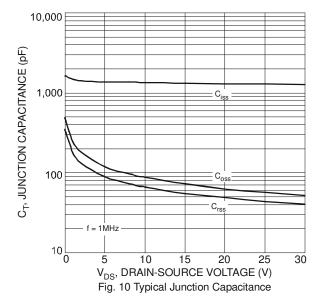
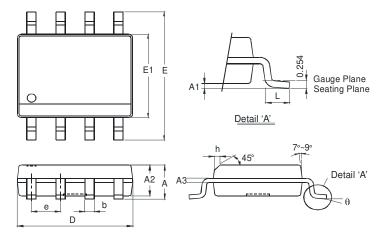


Fig. 8 Gate Threshold Variation vs. Ambient Temperature



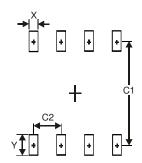


# **Package Outline Dimensions**



SO-8					
Dim	Min	Max			
Α	1	1.75			
<b>A</b> 1	0.10	0.20			
A2	1.30	1.50			
А3	0.15	0.25			
b	0.3	0.5			
D	4.85	4.95			
Е	5.90	6.10			
E1	3.85	3.95			
е	1.27 Typ				
h	-	0.35			
L	0.62	0.82			
θ	0°	8°			
All Dimensions in mm					

# **Suggested Pad Layout**



Dimensions	Value (in mm)
Х	0.60
Υ	1.55
C1	5.4
C2	1.27



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